



JPW

XA-9652A

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Kazuki HONMA et al.

Appln. No.: 10/718,562

Group Art Unit: 2818

Filed: November 24, 2003

Examiner: S. Mai

For: SEMICONDUCTOR DEVICE AND METHOD OF THE SEMICONDUCTOR  
DEVICE

Allowed: February 11, 2005

Confirmation No.: 1859

\* \* \*

REQUEST FOR ENDORSED COPY OF FORM PTO-1449

Commissioner for Patents  
P.O. Box 1450  
Alexandria, Virginia 22313-1450

Attn: Mail Stop Issue Fee

Sir:

Regarding the Information Disclosure Statement filed 11-24-03, the Information Disclosure Statement included Form PTO-1449 listing the documents. A copy of the Form which was filed on November 24, 2003 is submitted herewith. Applicants respectfully request a copy of the Form endorsed by the Examiner in the usual manner.

The Commissioner is hereby authorized to charge to Deposit Account No. 50-1165 any fees under 37 C.F.R. §§ 1.16 and 1.17 that may be required by this paper and to credit any overpayment to that Account. If any extension of time is required in connection with the filing of this paper and

has not been requested separately, such extension is hereby requested.

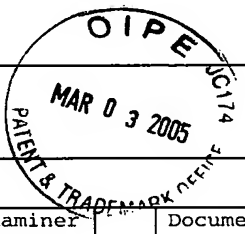
Respectfully submitted,

NHS:lmb

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March 3, 2005

By: Nelson H. Shapiro  
Nelson H. Shapiro  
Reg. No. 17,095

<b>FORM PTO-1449</b>				<b>Atty. Docket No.</b> <b>XA-9652A</b>		<b>Appln. No.</b>	
<b><u>LIST OF DOCUMENTS CITED BY APPLICANT</u></b>				<b>Applicant</b> <b>Kazuki Honma et al.</b>			
				<b>Filing Date</b> <b>HEREWITH</b>		<b>Group</b>	
<b>U.S. PATENT DOCUMENTS</b>							
<b>Examiner Initial</b>		<b>Document Number</b>	<b>Date</b>	<b>Name</b>	<b>Class</b>	<b>Sub-class</b>	<b>Filing Date</b>
	AA	6,226,224	05/2001	Banba et al.	365	226	
	AB	6,288,599	09/2001	Coddington	327	530	
	AC	5,363,335	11/1994	Jungroth et al.	365	226	
	AD	5,828,892	10/1998	Mizuta	713	300	
	AE	6,434,044	08/2002	Gongwer et al.	365	185.18	
	AF	6,515,507	02/2003	Patel et al.	326	38	
	AG						
	AH						
	AI						
	AJ						
	AK						
<b>FOREIGN PATENT DOCUMENTS</b>							
<b>Examiner Initial</b>		<b>Document Number</b>	<b>Date</b>	<b>Country</b>	<b>Class</b>	<b>Sub-class</b>	<b>Translation</b>
	AL						
	AM						
	AN						
	AO						
	AP						
<b>OTHER</b> (including author, title, date, pertinent pages, etc.)							
	AQ						
	AR						
	AS						
<b>Examiner</b>				<b>Date Considered</b>			
<b>EXAMINER:</b> Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							